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EXAMINER IN THE TRADEMARK OFFICE				Document Number (Optional)	Application Number		
				TSMC-00-2848	10/613,607		
				Applicant	Kuo-Reay Peng et al.		
				Filing Date	07/03/03		
				Cross Reference			
U. S. PATENT DOCUMENTS							
	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	ALM DATE IF APPROPRIATE	
<i>(Leave blank if no U.S. patent documents are cited.)</i>							
FOREIGN PATENT DOCUMENTS							
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation YES <input type="checkbox"/> NO <input checked="" type="checkbox"/>	
<i>(Leave blank if no foreign patent documents are cited.)</i>							
OTHER DOCUMENTS (Including Author, Title, Date, Page(s), Etc.)							
MC	Kleveland et al., "Distributed ESD Protection for High-Speed Integrated Circuits," IEEE Electron Device Letters, Vol. 21, No. 8, Aug. 2000, IEEE.						
EXAMINER	<i>[Signature]</i>			DATE CONSIDERED			
				6/11/04			
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